## Road Map

In chapter 2, we will consider the initial case about statistic estimate,  $\cdots$ 

## Chapter2: A Gentle Start

This chapter is talking about a general model of machine learning and common error.

#### 2.1 Formal Model.

- The learner's input
- · **Domain set:** An arbitrary set,  $\chi$ . This is the set of objects that we may wish to label.
- Label set: The Answer of the Domain set, usually  $\{0,1\}$  or  $\{-1,+1\}$
- · Training data:  $S = ((x_1, y_1), \dots, (x_m, y_m))$  is a sequence of labeled domain points.
- The learner's output
- ·  $h: \chi \to y$ , a prediction function, also called a predictor, hypothesis, classifier. Formally, the learner should choose tin advance a set of predictors. This set is called a hypothesis class and is denoted by H. Each  $h \in H$  is a function mapping from  $\chi$  to y.

#### • Other tools for ML

- · A data-generation model: We now explain how the training data is generated by som probability distribution. Let us denote that probability distribution over  $\chi$  by D.
- Measure of Success: To know is the output is good or not, we define the loss function to check it
  - (a) **True error:**  $L_{D,f}(h) = \mathbb{P}_{x \sim D}[h(x) \neq f(x)] = D(\{x \mid h(x) \neq f(x)\})$
  - (b) Training error:  $L_S(h) = \frac{|\{i \in m \mid h(x_i) \neq y_i\}|}{m}$  where  $[m] = \{1, \dots, m\}$

picture here (same training error but different true error)

- · We denote the probability of getting a non-representative sample by  $\delta$ , and call  $(1 \delta)$  the **confidence parameter** of our prediction
- · The accuracy parameter, commonly denoted by  $\epsilon$ . We interpret the event  $L_{(D,f)}(h_s) > \epsilon$  as a failure of the learner

## 2.2 Improve Model.

## **Empirical Risk Minimization**

The method to proof the model is to minimize the loss function by using training data, i.e. we check  $L_S(h)$ 

The ERM<sub>H</sub> learner uses the ERM rule to choose a predictor  $h \in H$ , with the lowest possible error over S. Formally

$$h_S = \text{ERM}_H(S) \in \arg\min_{h \in H} L_S(h)$$

## Overfitting

cause by ERM, the data is too fit the training set

example: 
$$h_s(x) = \begin{cases} y_i \text{ if } \exists i \in [m] \text{ s.t. } x_i = x \\ 0 \text{ otherwise} \end{cases}$$

## 2.3 The upper bound of $L_{(D,f)}(h_s)$ in finite hypothsis.

Restricting the learner to choosing a predictor from H are often called an **inductive** bias. In following statement, we will proof that when we have some assumption, H is a finite set and have enough quantity of data set, then we can avoid the overfitting problem.

#### some assumption

- The Realizability Assumption: There exists  $h^* \in H$  s.t.  $L_{(D,f)}(h^*) = 0$ . Note that this assumption implies that with probability 1 over random samples, S where the instances of S are sampled according to D and are labeled by f, we have  $L_S(h^*) = 0$
- The i.i.d. assumption: The examples in the training set are independently an identically distributed (i.i.d) according to the distribution D. We denote this assumption by  $S \sim D^m$  where m is the size of S, and  $D^m$  denotes the probability over m-tuples induced by applying D to pick each element of the tuple independently of the other members of the tuple.

#### **Proof Section**

The goal is to proof when  $m \ge \frac{\log(|H|/\delta)}{\epsilon}$ , then  $L_{D,f}(h_s) \le \epsilon$ Let  $H_B$  be the set of "bad" hypotheses, that is,

$$H_B = \{ h \in H \mid L_{D,f}(h) > \epsilon \}$$

In addition, let

$$M = \{ S|_x \mid \exists h \in H_B, L_S(h) = 0 \}$$

be the set of **misleading sample**(they are bad but  $L_S(h_S) = 0$ )

by definition, we can write

$$\{S|_x \mid L_{(D,f)}(h_S) > \epsilon \} \subseteq M(\star_1)$$

We can rewrite M as

$$M = \bigcup_{h \in H_B} \{ S|_x \mid L_S(h) = 0 \} (\star_2)$$

by  $(\star_1), (\star_2),$ 

$$D^{m}(\{S|_{x} \mid L_{(D,f)}(h_{s}) > \epsilon\}) \leq D^{m}(M) = D^{m}(\bigcup_{h \in H_{B}} \{S|_{x} \mid L_{S}(h) = 0\}) (\star_{3})$$

**LEMMA**(Union Bound) For any two sets A, B and a distribution D we have

$$D(A \cup B) \le D(A) + D(B)$$

and the  $(\star_3)$  can be bound like this

$$D^{m}(\{S|_{x} \mid L_{(D,f)}(h_{S}) > \epsilon\}) \leq \sum_{h \in H_{B}} D^{m}(\{S|_{x} \mid L_{S}(h) = 0\})(\star_{4})$$

Next, we focus on the bad hypothesis  $h \in H_B \implies L_{(D,f)}(h) > \epsilon$  because the event are i.i.d, we get that

$$D^{m}(\{S|_{x} \mid L_{S}(h) = 0\}) = D^{m}(\{S|_{x} \mid \forall i, h(x_{i}) = f(x_{i}) = f(x_{i})\}) = \prod_{i=1}^{m} D(\{x_{i} \mid h(x_{i}) = f(x_{i})\}) (\star_{5})$$

check the each individual sampling of an element of the training set, we have

$$D(\{x_i \mid h(x_i) = y_i\}) = 1 - L_{D,f}(h) \le 1 - \epsilon$$

put it to the  $(\star_5)$  and use the inequality  $1 - \epsilon \le e^{-\epsilon}$ 

$$D^{m}(\{ S|_{x} \mid L_{S}(h) = 0 \}) \leq (1 - \epsilon)^{m} \leq e^{-\epsilon m} (\star_{6})$$

put  $(\star_6)$  back to  $(\star_4)$ 

$$D^{m}(\left\{ S|_{x} \mid L_{(D,f)}(h_{S}) > \epsilon \right\}) \leq |H_{B}|e^{-\epsilon m} \leq |H|e^{-\epsilon m}$$

# Chapter5: The Bias-Complexity Tradeoff

First, we can decomposition the error to following terms:

$$L_D(h_s) = \epsilon_{app} + \epsilon_{est}$$
 where:  $\epsilon_{app} = \min_{h \in H} L_D(h), \ \epsilon_{est} = L_D(h_s) - \epsilon_{app}$ 

Error type

- · The Approximation  $\mathrm{Error}(\epsilon_{app})$
- · The Estimation  $\operatorname{Error}(\epsilon_{est})$

Bias-complexity Tradeoff